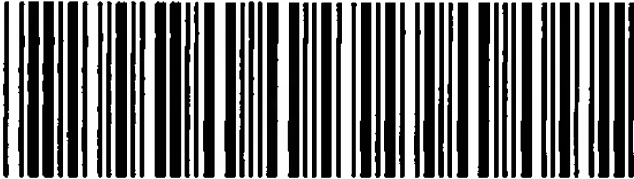


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/668,862	BAROUDY ET AL.	
	Examiner	Art Unit	
	Shengjun Wang	1617	

SEARCHED			
Class	Subclass	Date	Examiner
514	252.12, 252.13 252.19	6/29/2007	SW
514	253.01	6/29/2007	SW
514	253.1	6/29/2007	SW
514	253.11	6/29/2007	SW

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
STN structure,	6/29/2007	SW
transplant, rejection, CCR5		
parent applications	6/29/2007	SW
inventor search	6/29/2007	SW